## Notice of References Cited Application/Control No. O9/826,786 Applicant(s)/Patent Under Reexamination MONTOYA, PATRICK Examiner Johnna R. Loftis Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,311,190	10-2001	Bayer et al.	707/104.1
*	В	US-6,510,427	01-2003	Bossemeyer et al.	707/6
*	С	US-6,963,848	11-2005	Brinkerhoff, Richard	705/10
*	D	US-6,151,707	11-2000	Hecksel et al.	717/178
*	E	US-6,819,759	11-2004	Khuc et al.	379/309
*	F	US-5,950,172	09-1999	Klingman, Edwin E.	705/26
*	G	US-6,735,572	05-2004	Landesmann, Mark	705/14
*	н	US-6,760,727	07-2004	Schroeder et al.	707/10
*	Т	US-5,668,953	09-1997	Sloo, Marshall Allan	705/1
*	J	US-6,618,504	09-2003	Yoshino, Eiko	382/187
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	α					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.